DMTH41M8SPS
$40 \mathrm{~V}+175^{\circ} \mathrm{C}$ N-CHANNEL ENHANCEMENT MODE MOSFET
PowerDI5060-8

## Product Summary

| BV DSS | RDS(ON) Max | $\mathbf{I}_{\mathbf{D}}$ <br> $\mathbf{T C}=+\mathbf{2 5}{ }^{\circ} \mathbf{C}$ <br> (Note 9) |
| :---: | :---: | :---: |
| 40 V | $1.8 \mathrm{~m} \Omega @ \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}$ | 100 A |

## Description and Applications

This MOSFET is designed to minimize the on-state resistance ( $\mathrm{R}_{\mathrm{DS}(\mathrm{ON})}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications

- Engine Management Systems
- Body Control Electronics
- DC-DC Converters


## Features

- Rated to $+175^{\circ} \mathrm{C}$ - Ideal for High Ambient Temperature Environments
- $100 \%$ Unclamped Inductive Switching (UIS) Test in Production Ensures More Reliable and Robust End Application
- Thermally Efficient Package-Cooler Running Applications
- High Conversion Efficiency
- Low Rds(ON) - Minimizes On State Losses
- $\quad<1.1 \mathrm{~mm}$ Package Profile - Ideal for Thin Applications
- Lead-Free Finish; RoHS Compliant (Notes 1 \& 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- An Automotive-Compliant Part is Available Under Separate Datasheet (DMTH41M8SPSQ)


## Mechanical Data

- Case: PowerDI ${ }^{\circledR} 5060-8$
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Finish - Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 e3
- Weight: 0.097 grams (Approximate)



Internal Schematic


Top View Pin Configuration

## Ordering Information (Note 4)

| Part Number | Case | Packaging |
| :---: | :---: | :---: |
| DMTH41M8SPS-13 | PowerDI5060-8 (Type K) | $2,500 /$ Tape \& Reel |

Notes: 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) \& 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain $<900 \mathrm{ppm}$ bromine, $<900 \mathrm{ppm}$ chlorine ( $<1500 \mathrm{ppm}$ total $\mathrm{Br}+\mathrm{Cl}$ ) and <1000ppm antimony compounds
4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

## Marking Information



PowerDI is a registered trademark of Diodes Incorporated.
Jil=Manufacturer's Marking TH41M8SS = Product Type Marking Code YYWW = Date Code Marking $\mathrm{YY}=$ Last Two Digits of Year (ex: $19=2019$ ) WW = Week Code (01 to 53)

DMTH41M8SPS

Maximum Ratings $\left(@ T_{A}=+25^{\circ} \mathrm{C}\right.$, unless otherwise specified.)

| Characteristic |  | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: | :---: |
| Drain-Source Voltage |  | VDSS | 40 | V |
| Gate-Source Voltage |  | $\mathrm{V}_{\text {GSS }}$ | $\pm 20$ | V |
| Continuous Drain Current, VGS $=10 \mathrm{~V}$ (Notes 6 \& 9) | $\begin{gathered} \mathrm{T}_{\mathrm{C}}=+25^{\circ} \mathrm{C} \\ \mathrm{~T}_{\mathrm{C}}=+100^{\circ} \mathrm{C} \end{gathered}$ | ID | $\begin{aligned} & \hline 100 \\ & 100 \end{aligned}$ | A |
| Pulsed Drain Current (10رs Pulse, Duty Cycle = 1\%) |  | IDM | 400 | A |
| Pulsed Body Diode Forward Current (10ヶs Pulse, Duty Cycle = 1\%) |  | ISM | 400 | A |
| Continuous Body Diode Forward Current (Note 7) | $\mathrm{T}_{\mathrm{C}}=+25^{\circ} \mathrm{C}$ | Is | 100 | A |
| Avalanche Current, $\mathrm{L}=0.1 \mathrm{mH}$ |  | $\mathrm{I}_{\text {AS }}$ | 72.8 | A |
| Avalanche Energy, $\mathrm{L}=0.1 \mathrm{mH}$ |  | $\mathrm{E}_{\text {AS }}$ | 265 | mJ |

## Thermal Characteristics

| Characteristic | Symbol | Value | Unit |
| :--- | :---: | :---: | :---: |
| Total Power Dissipation (Note 5) | $\mathrm{P}_{\mathrm{D}}$ | 3.03 | W |
| Thermal Resistance, Junction to Ambient (Note 5) | $\mathrm{R}_{\theta J A}$ | 49 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Total Power Dissipation (Note 6) | $\mathrm{P}_{\mathrm{D}}$ | 150 | $\mathrm{~W}^{\prime 2}$ |
| Thermal Resistance, Junction to Case (Note 6) | $\mathrm{R}_{\theta J \mathrm{C}}$ | 1.0 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Operating and Storage Temperature Range | $\mathrm{T}_{\mathrm{J}, \mathrm{T}, \mathrm{T} G}$ | -55 to +175 | ${ }^{\circ} \mathrm{C}$ |

Electrical Characteristics ( $@ T_{A}=+25^{\circ} \mathrm{C}$, unless otherwise specified.)

| Characteristic | Symbol | Min | Typ | Max | Unit | Test Condition |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OFF CHARACTERISTICS (Note 7) |  |  |  |  |  |  |
| Drain-Source Breakdown Voltage | $\mathrm{BV}_{\text {DSS }}$ | 40 | - | - | V | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |
| Zero Gate Voltage Drain Current | IDSS | - | - | 1 | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{DS}}=32 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |
| Gate-Source Leakage | IGSS | - | - | $\pm 100$ | nA | $\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ |
| ON CHARACTERISTICS (Note 7) |  |  |  |  |  |  |
| Gate Threshold Voltage | V GS(TH) | 2 | - | 4 | V | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |
| Static Drain-Source On-Resistance | $\mathrm{R}_{\mathrm{DS} \text { (ON) }}$ | - | 1.4 | 1.8 | $\mathrm{m} \Omega$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=30 \mathrm{~A}$ |
| Diode Forward Voltage | $\mathrm{V}_{\text {SD }}$ | - | 0.8 | 1.2 | V | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{IS}=20 \mathrm{~A}$ |
| DYNAMIC CHARACTERISTICS (Note 8) |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | - | 6968 | - | pF | $\begin{aligned} & V_{\mathrm{DS}}=20 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \\ & \mathrm{f}=1 \mathrm{MHz} \end{aligned}$ |
| Output Capacitance | $\mathrm{C}_{\text {oss }}$ | - | 1812 | - |  |  |
| Reverse Transfer Capacitance | Crss | - | 59 | - |  |  |
| Gate Resistance | $\mathrm{R}_{\mathrm{G}}$ | - | 1.21 | - | $\Omega$ | $\mathrm{V}_{\mathrm{DS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{g}}$ | - | 79.5 | - | nC | $\begin{aligned} & V_{D D}=20 \mathrm{~V}, I_{D}=90 \mathrm{~A}, \\ & V_{G S}=10 \mathrm{~V} \end{aligned}$ |
| Gate-Source Charge | $\mathrm{Qgss}^{\text {g }}$ | - | 20.6 | - |  |  |
| Gate-Drain Charge | $\mathrm{Q}_{\mathrm{gd}}$ | - | 16.5 | - |  |  |
| Turn-On Delay Time | tb(0N) | - | 13.3 | - | ns | $\begin{aligned} & V_{\mathrm{DD}}=20 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}, \\ & \mathrm{ID}_{\mathrm{D}}=90 \mathrm{~A}, \mathrm{R}_{\mathrm{G}}=3.5 \Omega \end{aligned}$ |
| Turn-On Rise Time | $\mathrm{t}_{\mathrm{R}}$ | - | 41.3 | - |  |  |
| Turn-Off Delay Time | tD(OFF) | - | 35.1 | - |  |  |
| Turn-Off Fall Time | $\mathrm{t}_{\mathrm{F}}$ | - | 13.7 | - |  |  |
| Reverse Recovery Time | trR | - | 62 | - | ns | $\mathrm{lf}=50 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ |
| Reverse Recovery Charge | QRR | - | 103 | - | nC |  |

Notes: $\quad$. Device mounted on FR-4 substrate PC board, 2 oz copper, with thermal bias to bottom layer 1inch square copper plate.
6. Thermal resistance from junction to soldering point (on the exposed drain pad).
7. Short duration pulse test used to minimize self-heating effect.
8. Guaranteed by design. Not subject to product testing.
9. Limited by package.

$V_{\text {DS }}$, DRAIN-SOURCE VOLTAGE (V)
Figure 1. Typical Output Characteristic


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

$\mathrm{V}_{\mathrm{Gs}}$, GATE-SOURCE VOLTAGE (V)
Figure 2. Typical Transfer Characteristic

$V_{\text {GS }}$, GATE SOURE Trantic


Figure 6. On-Resistance Variation with Temperature

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Figure 7. On-Resistance Variation with Temperature


Figure 9. Diode Forward Voltage vs. Current


Figure 11. Gate Charge


Figure 8. Gate Threshold Variation vs. Junction
Temperature


Figure 10. Typical Junction Capacitance


Figure 12. SOA, Safe Operation Area

DMTH41M8SPS


Figure 13. Transient Thermal Resistance

DMTH41M8SPS

## Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI5060-8 (Type K)


| $\begin{gathered} \text { PowerDI5060-8 } \\ \text { (Type K) } \end{gathered}$ |  |  |  |
| :---: | :---: | :---: | :---: |
| Dim | Min | Max | Typ |
| A | 0.90 | 1.10 | 1.00 |
| A1 | 0 | 0.05 | 0.02 |
| b | 0.33 | 0.51 | 0.41 |
| b1 | 0.300 | 0.366 | 0.333 |
| b2 | 0.20 | 0.35 | 0.25 |
| c | 0.23 | 0.33 | 0.277 |
| D | 5.15 BSC |  |  |
| D1 | 4.85 | 4.95 | 4.90 |
| D2 |  | - | 3.98 |
| E | 6.15 BSC |  |  |
| E1 | 5.75 | 5.85 | 5.80 |
| E2 | 3.56 | 3.725 | 3.66 |
| e | 1.27BSC |  |  |
| k | - | - | 1.27 |
| L | 0.51 | 0.71 | 0.61 |
| La | 0.51 | 0.675 | 0.61 |
| L1 | 0.05 | 0.20 | 0.175 |
| L4 | - | - | 0.125 |
| M | 3.50 | 3.71 | 3.605 |
| $\mathbf{x}$ | - | - | 1.400 |
| y | - | - | 1.900 |
| $\theta$ | $10^{\circ}$ | $12^{\circ}$ | $11^{\circ}$ |
| $\theta 1$ | $6^{\circ}$ | $8^{\circ}$ | $7^{\circ}$ |
| All Dimensions in mm |  |  |  |

## Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.
PowerDI5060-8 (Type K)


| Dimensions | Value <br> (in mm) |
| :---: | :---: |
| $\mathbf{C}$ | 1.270 |
| $\mathbf{G}$ | 0.660 |
| G1 | 0.820 |
| $\mathbf{X}$ | 0.610 |
| $\mathbf{X 1}$ | 3.910 |
| $\mathbf{X 2}$ | 4.420 |
| $\mathbf{Y}$ | 1.270 |
| $\mathbf{Y 1}$ | 1.020 |
| $\mathbf{Y 2}$ | 3.810 |
| $\mathbf{Y 3}$ | 6.610 |

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